



Application Serial No. 09/677,478
Supplemental IDS

MI22-1544

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No.09/677,478
Filing DateOctober 2, 2000
InventorGuy T. Blalock et al.
AssigneeMicron Technology, Inc.
Group Art Unit1765
ExaminerLan Vinh
Attorney's Docket No.MI22-1544
Title: Plasma Etching Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

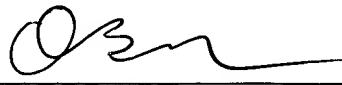
Reference -- See attached Form PTO-1449

The attached Form PTO-1449 is submitted in compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the references listed on the attached Form PTO-1449. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art references, if any, are attached. No admission is made regarding whether the submitted references are prior art.

Citation of this reference is respectfully requested.

Respectfully submitted,

Dated: 6-26-06

By: 
D. Brent Kenady
Reg. No. 40,045

| <p>Form PTO-1449 JUN 26 2006 U.S. PATENT & TRADEMARK OFFICE</p> <p>U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</p> <p>LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)</p> | | | | | ATTY. DOCKET NO. MI22-1544 | | SERIAL NO. 09/677,478 | |
|---|----|-----------------|-------|-----------|------------------------------------|----------|----------------------------|----|
| | | | | | APPLICANT Guy T. Blalock et al. | | | |
| | | | | | FILING DATE October 2, 2000 | | GROUP 1765 | |
| U.S. PATENT DOCUMENTS | | | | | | | | |
| Examiner's Initials | | Document Number | Date | Name | Class | Subclass | Filing Date If Appropriate | |
| | AA | 6,800,561 | 10/04 | Allen III | 438 | 714 | | |
| | AB | 6,878,300 B2 | 04/05 | Allen III | 216 | 058 | | |
| | AC | | | | | | | |
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| FOREIGN PATENT DOCUMENTS | | | | | | | | |
| | | Document Number | Date | Country | Class | Subclass | Translation | |
| | AM | | | | | | Yes | No |
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| OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | |
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| <p>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p> | | | | | | | | |